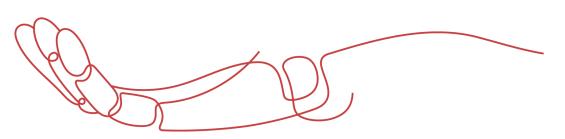


PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at







Datasheet

Samples

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

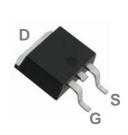
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

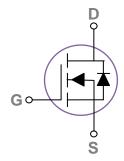
BVDSS	RDSON	ID
100V	75m Ω	15A

Features

- $100V,15A, RDS(ON) = 75m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

TO252 Pin Configuration





Applications

- Networking
- Load Switch
- LED applications

Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	±20	V
	Drain Current – Continuous (T _C =25°C)	15	А
ID	Drain Current – Continuous (T _C =100°C)	9.5	А
I _{DM}	Drain Current – Pulsed ¹	60	А
D	Power Dissipation (T _C =25°C)	50	W
P_{D}	Power Dissipation – Derate above 25°C	0.4	W/°C
T _{STG}	Storage Temperature Range	-50 to 150	°C
TJ	Operating Junction Temperature Range	-50 to 125	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case		2.5	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Symbol Parameter Conditions		Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =250uA	100			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.05		V/°C
	Drain Source Leekage Current	V _{DS} =100V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =80V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

В	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =5A		75	95	mΩ
R _{DS(ON)}	Static Dialii-Source Off-Resistance	V _{GS} =4.5V , I _D =3A	1.0	85	110	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, I_{D} =250uA	1.0	1.8	2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-5		mV/°C
gfs	Forward Transconductance	V_{DS} =10V , I_{D} =3A		8.7		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}		 9.3	13	
Q _{gs}	Gate-Source Charge ^{2,3}	V_{DS} =48V , V_{GS} =10V , I_{D} =5A	 2.1	4.2	nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		 1.8	4	
$T_{d(on)}$	Turn-On Delay Time ^{2,3}		 2.9	6	
Tr	Rise Time ^{2, 3}	V_{DD} =30V , V_{GS} =10V , R_{G} =3.3 Ω	 9.5	18	20
$T_{d(off)}$	Turn-Off Delay Time ^{2,3}	I _D =1A	 18.4	35	ns
T _f	Fall Time ^{2,3}		 5.3	10	
C _{iss}	Input Capacitance		 1480	2150	
C _{oss}	Output Capacitance	V_{DS} =50V , V_{GS} =0V , F=1MHz	 480	700	pF
C _{rss}	Reverse Transfer Capacitance		 35	55	
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, F=1MHz	 1.3	2.6	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol Parameter		Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			15	Α
I _{SM}	Pulsed Source Current	VG-VD-OV, Poice Current			60	Α
V_{SD}	Diode Forward Voltage	V_{GS} =0V , I_{S} =1A , T_{J} =25 $^{\circ}$ C			1	V
t _{rr}	Reverse Recovery Time ²	Vgs=30V,ls=1A , dl/dt=100A/µs				ns
Q_{rr}	Reverse Recovery Charge ²	T _J =25°C				nC

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. Essentially independent of operating temperature.



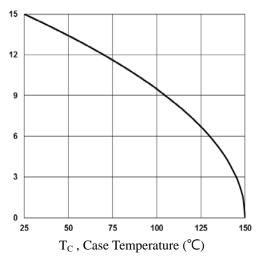


Fig.1 Continuous Drain Current vs. TC

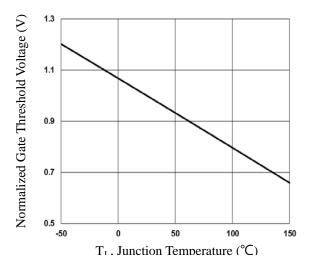


Fig.3 Normalized V_{th} vs. T_J

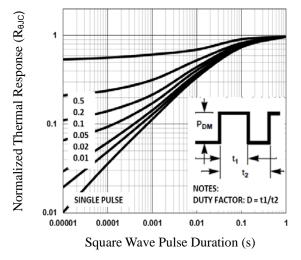


Fig.5 Normalized Transient Impedance

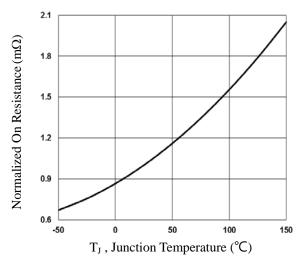


Fig.2 Normalized RDSON vs. TJ

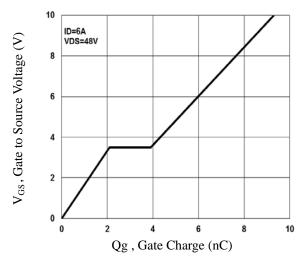


Fig.4 Gate Charge Characteristics

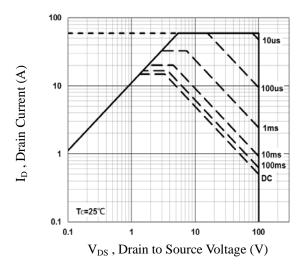
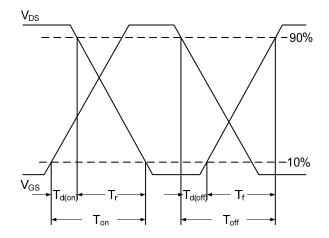


Fig.6 Maximum Safe Operation Area





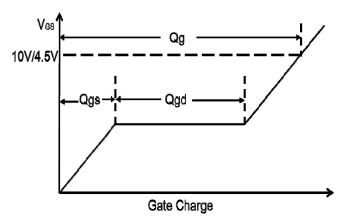
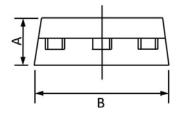


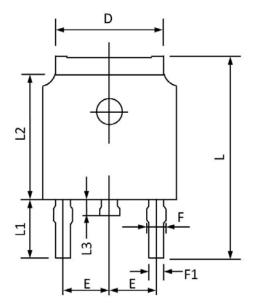
Fig.7 Switching Time Waveform

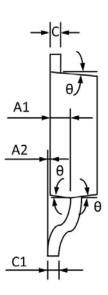
Fig.8 Gate Charge Waveform



TO252 PACKAGE INFORMATION







Cymb al	Dimensions I	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
A	2.20	2.40	0.087	0.094
A1	0.91	1.11	0.036	0.044
A2	0.00	0.15	0.000	0.006
В	6.50	6.70	0.256	0.264
C	0.46	0.580	0.018	0.230
C1	0.46	0.580	0.018	0.030
D	5.10	5.46	0.201	0.215
E	2.186	2.386	0.086	0.094
F	0.74	0.94	0.029	0.037
F1	0.660	0.860	0.026	0.034
L	9.80	10.40	0.386	0.409
L1	2.91	REF	0.114	REF
L2	6.00	6.20	0.236	0.244
L3	0.60	1.00	0.024	0.039
θ	3°	9°	3°	9°



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